

<b>Notice of References Cited</b>	Application/Control No. 10/814,059	Applicant(s)/Patent Under Reexamination KWAK ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0013472	08-2001	Nakamura et al.	205/103
*	B	US-2003/0178315	09-2003	Taylor, E. Jennings	205/103
	C	US-			
	D	US-			
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	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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